


<b>Search Notes</b>  	<b>Application/Control No.</b>  10537497	<b>Applicant(s)/Patent Under Reexamination</b>  NAKANISHI ET AL.
	<b>Examiner</b>  RYAN OCHYLSKI	<b>Art Unit</b>  4151

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Performed inventor name search	8/13/2008	RMO
Consulted with Examiners Randy Gulakowski and Robert Sellers	8/13/2008	RMO
No EAST search performed. The art not cited in the IDS was found by a STIC NPL search.	8/18/2008	RMO

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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